150V, 14A, 51mΩ N-channel Power SGT MOSFET

JMSH1552PU

Features

- $\bullet \quad \text{Excellent $R_{\text{DS(ON)}}$ and Low Gate Charge}$
- 100% UIS Tested
- 100% ΔVds Tested
- Halogen-free; RoHS-compliant

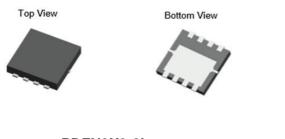
Applications

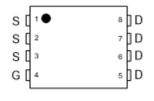
- Load Switch
- PWM Application
- Power Management

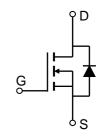
Product Summary

| Parameters | Value | Unit |
|-------------------------------|-------|------|
| V_{DSS} | 150 | V |
| $V_{GS(th)_Typ}$ | 3.3 | V |
| $I_D(@V_{GS}=10V)$ | 14 | Α |
| $R_{DS(ON)_Typ}(@V_{GS}=10V$ | 51 | mΩ |









PDFN3X3-8L

Pin Assignment

Schematic Diagram

Ordering Information

| Device | Marking | MSL | Form | Package | Reel(pcs) | Per Carton (pcs) |
|---------------|---------|-----|-----------|------------|-----------|------------------|
| JMSH1552PU-13 | SH1552P | 1 | Tape&Reel | PDFN3x3-8L | 5000 | 50000 |

Absolute Maximum Ratings (@ T_C = 25°C unless otherwise specified)

| Symbol | Parameter | | Value | Unit |
|------------------|--------------------------------------|---------------------|----------------|------|
| V_{DS} | Drain-to-Source Voltage | | 150 | V |
| V_{GS} | Gate-to-Source Voltage | | ±20 | V |
| I- | Continuous Drain Current | $T_C = 25^{\circ}C$ | 14 | ^ |
| I _D | | $T_C = 100$ °C | 9 | Α |
| I_{DM} | Pulsed Drain Current (1) | | Refer to Fig.4 | Α |
| E _{AS} | Single Pulsed Avalanche Energy (2) | | 60 | mJ |
| P _D | DOWAR DISSIDATION L | $T_C = 25^{\circ}C$ | 28 | W |
| | | $T_C = 100$ °C | 11 |] vv |
| T_{J}, T_{STG} | Junction & Storage Temperature Range | | -55 to 150 | °C |

Thermal Characteristics

| Symbol | Parameter | Max | Unit |
|-----------------|--|-----|------|
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient ⁽³⁾ | 42 | °C/W |
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 4.4 | C/VV |



Electrical Characteristics (T_J = 25°C unless otherwise specified)

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|---------------------|--|--|------|------|------|--------------|
| Off Cha | racteristics | | | ļ. | | |
| $V_{(BR)DSS}$ | Drain-Source Breakdown Voltage | $I_D = 250 \mu A, V_{GS} = 0 V$ | 150 | - | - | V |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 120V, V_{GS} = 0V$ | - | - | 1.0 | μА |
| I _{GSS} | Gate-Body Leakage Current | $V_{DS} = 0V, V_{GS} = \pm 20V$ | - | - | ±100 | nA |
| On Cha | racteristics | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 2.3 | 3.3 | 4.3 | V |
| R _{DS(ON)} | Static Drain-Source ON-Resistance ⁽⁴⁾ | $V_{GS} = 10V, I_{D} = 10A$ | - | 51 | 67 | mΩ |
| Dynami | ic Characteristics | | | | | |
| R_{g} | Gate Resistance | f = 1MHz | - | 1.1 | - | Ω |
| C _{iss} | Input Capacitance | \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ | 538 | 753 | 1016 | pF |
| C _{oss} | Output Capacitance | $V_{GS} = 0V, V_{DS} = 75V,$ $f = 1MHz$ | 55 | 77 | 104 | pF |
| C _{rss} | Reverse Transfer Capacitance | | - | 12 | - | pF |
| Qg | Total Gate Charge | | - | 11 | 17 | nC |
| Q_{gs} | Gate Source Charge | $V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 75V, I_{D} = 10A$ | - | 5 | - | nC |
| Q_{gd} | Gate Drain("Miller") Charge | V DS = 70V, ID = 10A | - | 2.4 | - | nC |
| 0 1/ 1 1 | | | | | | |
| | ing Characteristics | | | I . | | l |
| t _{d(on)} | Turn-On DelayTime | - | - | 8 | - | ns |
| t _r | Turn-On Rise Time | $V_{GS} = 10V, V_{DD} = 75V$ | - | 14 | - | ns |
| t _{d(off)} | Turn-Off DelayTime | $I_D=10A, R_{GEN}=3\Omega$ | - | 11 | - | ns |
| t _f | Turn-Off Fall Time | | - | 2.8 | - | ns |
| Body D | iode Characteristics | | | 1 | ı | - |
| I _S | Maximum Continuous Body Diode Forward Current | | - | - | 14 | А |
| I _{SM} | Maximum Pulsed Body Diode Forward Curr | ent | - | - | 54 | Α |
| V_{SD} | Body Diode Forward Voltage | $V_{GS} = 0V, I_{S} = 10A$ | - | | 1.2 | V |
| trr | Body Diode Reverse Recovery Time | I _F = 10A, di/dt = 100A/us | 46 | 65 | 88 | ns |
| Qrr | Body Diode Reverse Recovery Charge | $\mathbf{T}_{\mathrm{F}} = \mathrm{TOA}$, $\mathrm{di}/\mathrm{dt} = \mathrm{TOOA}/\mathrm{dS}$ | - | 142 | - | nC |

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

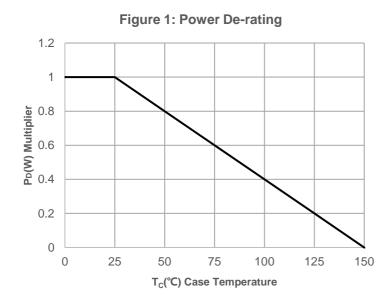
 $^{2.\;}E_{AS}\;condition:\;Starting\;T_{J}=25C,\;V_{DD}=75V,\;V_{GS}=10V,\;R_{G}=25ohm,\;L=3mH,\;I_{AS}=6.3A,\;V_{DD}=0V\;during\;time\;in\;avalanche.$

^{3.} $R_{\theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB.

^{4.} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 0.5%.



Typical Performance Characteristics



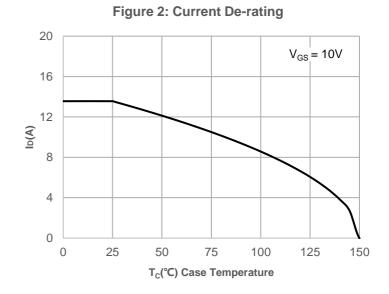
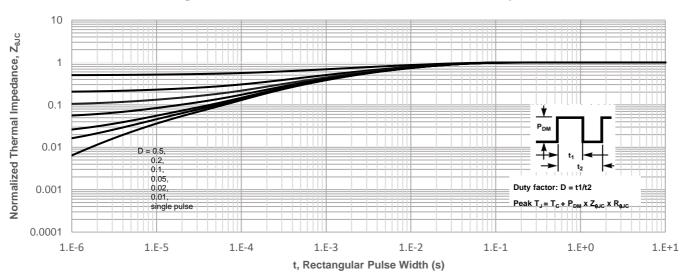
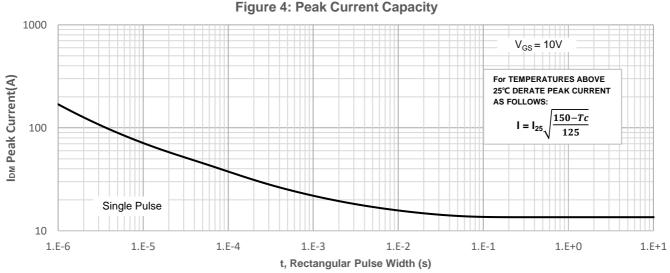


Figure 3: Normalized Maximum Transient Thermal Impedance







Typical Performance Characteristics

Figure 5: Output Characteristics

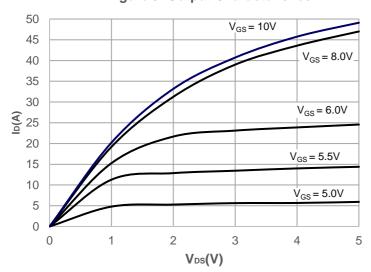


Figure 6: Typical Transfer Characteristics

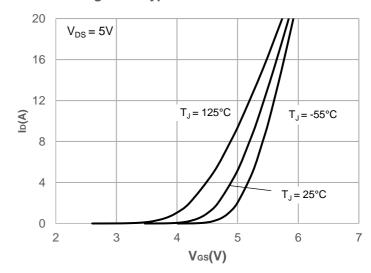


Figure 7: On-resistance vs. Drain Current

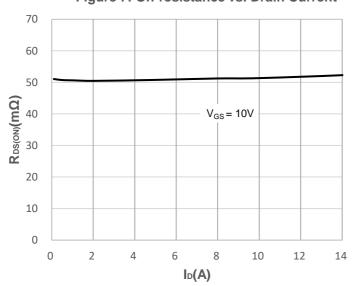


Figure 8: Body Diode Characteristics

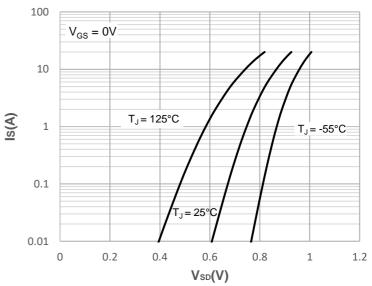


Figure 9: Gate Charge Characteristics

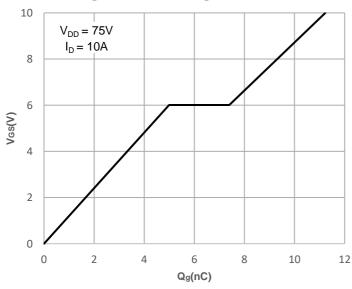
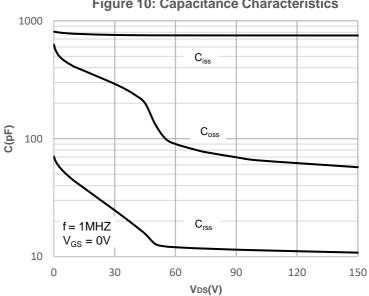


Figure 10: Capacitance Characteristics





Typical Performance Characteristics

Figure 11: Normalized Breakdown voltage vs. Junction Temperature

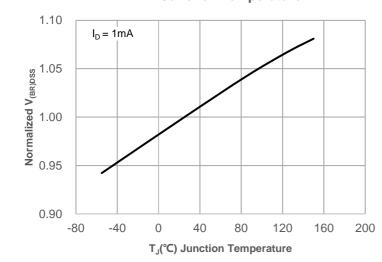


Figure 13: Normalized Threshold Voltage vs. Junction Temperature

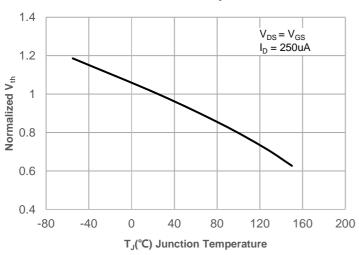


Figure 15: Maximum Safe Operating Area

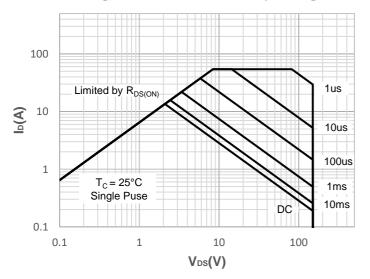
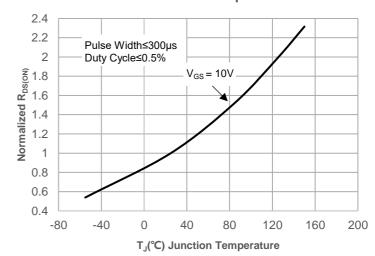
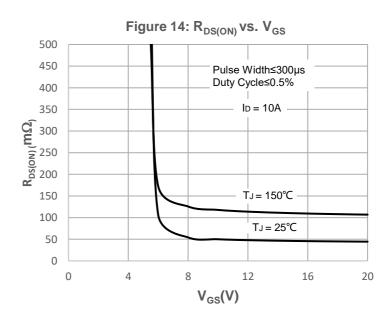


Figure 12: Normalized on Resistance vs. Junction Temperature







Test Circuit

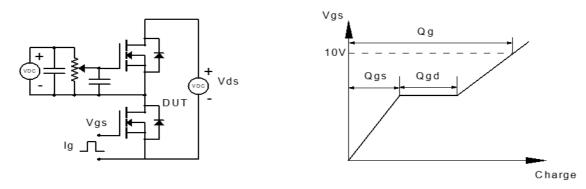


Figure 1: Gate Charge Test Circuit & Waveform

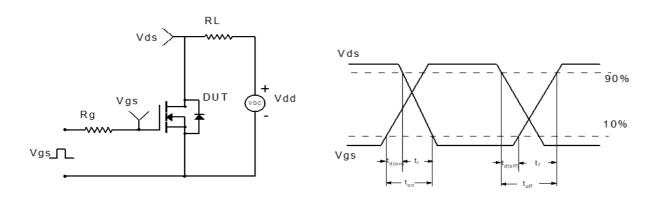


Figure 2: Resistive Switching Test Circuit & Waveform

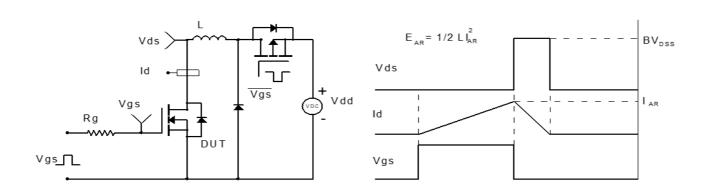


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

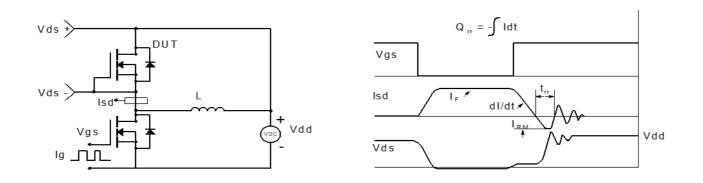
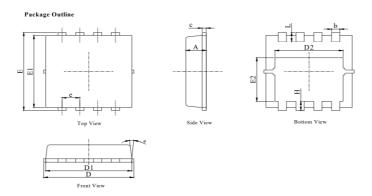


Figure 4: Diode Recovery Test Circuit & Waveform



Package Mechanical Data(PDFN3X3-8L)

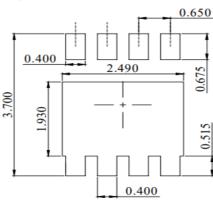


NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M,1994.
- ALL DIMNESIONS IN MILLIMETER (ANNGLE IN DEGREE).
 DIMENSIONS DI AND EI DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

| DIM | | MILLIMETER | |
|------|----------|------------|------|
| DIM. | MIN. | NOM. | MAX. |
| A | 0.70 | 0.75 | 0.80 |
| ь | 0.25 | 0.30 | 0.35 |
| С | 0.10 | 0.20 | 0.25 |
| D | 3.00 | 3.15 | 3.25 |
| D1 | 2.95 | 3.05 | 3.15 |
| D2 | 2.39 | 2.49 | 2.59 |
| E | 3.20 | 3.30 | 3.40 |
| E1 | 2.95 | 3.05 | 3.15 |
| E2 | 1.70 | 1.80 | 1.90 |
| e | 0.65 BSC | | |
| Н | 0.30 | 0.40 | 0.50 |
| L | 0.25 | 0.40 | 0.50 |
| a | | | 15° |

Recommended Soldering Footprint



Information furnished in this document is believed to be accurate and reliable. However, Jiangsu JieJie Microelectronics Co., Ltd assumes no responsibility for the consequences of use without consideration for such information nor use beyond it. Information mentioned in this document is subject to change without notice, apart from that when an agreement is signed, Jiangsu JieJie complies with the agreement. Products and information provided in this document have no infringement of patents. Jiangsu JieJie assumes no responsibility for any infringement of other rights of third parties which may result from the use of such products and information.

DIMENSIONS:MILLIMETERS



is a registered trademark of Jiangsu JieJie Microelectronics Co.,Ltd.